



N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)	
	$0.049 \text{ at V}_{GS} = 4.5 \text{ V}$	6.1 ^a		
20	0.056 at V _{GS} = 2.5 V	5.7	6.0	
	0.065 at V _{GS} = 1.8 V	5.3		

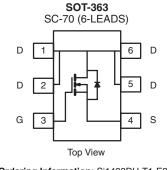
FEATURES

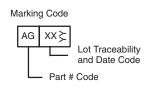
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_q and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

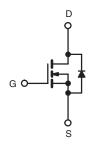


APPLICATIONS

· Load Switch for Portable Devices







Ordering Information: Si1488DH-T1-E3 (Lead (Pb)-free) Si1488DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	20	V	
Gate-Source Voltage		V_{GS}	± 8	¬	
	T _C = 25 °C		6.1		
Continuous Dusin Comment /T. 150 °C\d	T _C = 70 °C	1 . [4.9		
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 25 °C	- I _D	4.6 ^{b, c}		
	T _A = 70 °C]	3.7 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	20		
Avalanche Current	L = 0.1 mH	I _{AS}	10		
Repetitive Avalanche Energy	L=0.1 mn	E _{AS}	5	mJ	
Continuous Courses Brain Binds Coursest	T _C = 25 °C		2.3	Δ.	
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	1.3 ^{b, c}	Α	
	T _C = 25 °C		2.8		
Maximum Power Dissipation ^a	T _C = 70 °C		1.8	14/	
	T _A = 25 °C	P _D	1.5 ^{b, c}	W	
	T _A = 70 °C		1.0 ^{b, c}	1	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	60	80	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	34	45	C/VV	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- $c. \quad t=5 \ s.$
- d. Maximum under steady state conditions is 125 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•			•			
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 ·· A		20.2		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}$ /	I _D = 250 μA		- 2.75			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.45		0.95	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V			1	μΑ	
		V _{DS} = 20 V, V _{GS} = 0 V, T _J = 85 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α	
		V _{GS} = 4.5 V, I _D = 4.6 A		0.041	0.049		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 4.3 \text{ A}$		0.047	0.056	Ω	
	, ,	V _{GS} = 1.8 V, I _D = 3.9 A		0.054	0.065	1	
Forward Transconductance	9 _{fs}	V _{DS} = 10 V, I _D = 4.6 A		15		mS	
Dynamic ^b	•			•			
Input Capacitance	C _{iss}			530			
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		100		pF	
Reverse Transfer Capacitance	C _{rss}			48			
Total Octo Observe		$V_{DS} = 10 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 4.6 \text{ A}$		6.6	10		
Total Gate Charge	Qg			6	9	pC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.6 \text{ A}$		1.5			
Gate-Drain Charge	Q_{gd}			0.9			
Gate Resistance	R_{g}	f = 1 MHz		7.3	11	Ω	
Turn-On Delay Time	t _{d(on)}			8.5	13		
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 2.7 \Omega$		45	68		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 3.7 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		35	53	ns	
Fall Time	t _f			82	123		
Drain-Source Body Diode Characteristic	cs			•			
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			2.3	٨	
Pulse Diode Forward Current ^a	I _{SM}				20	A	
Body Diode Voltage	V_{SD}	I _S = 2.2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			10.6	16	nC	
Body Diode Reverse Recovery Charge Q _{rr}		1 00 4 41/24 400 4/25		3.7	5.7		
Reverse Recovery Fall Time	t _a	I _F = 3.2 A, dl/dt = 100 A/μs		6.2		ns	
Reverse Recovery Rise Time	t _b			4.4			

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

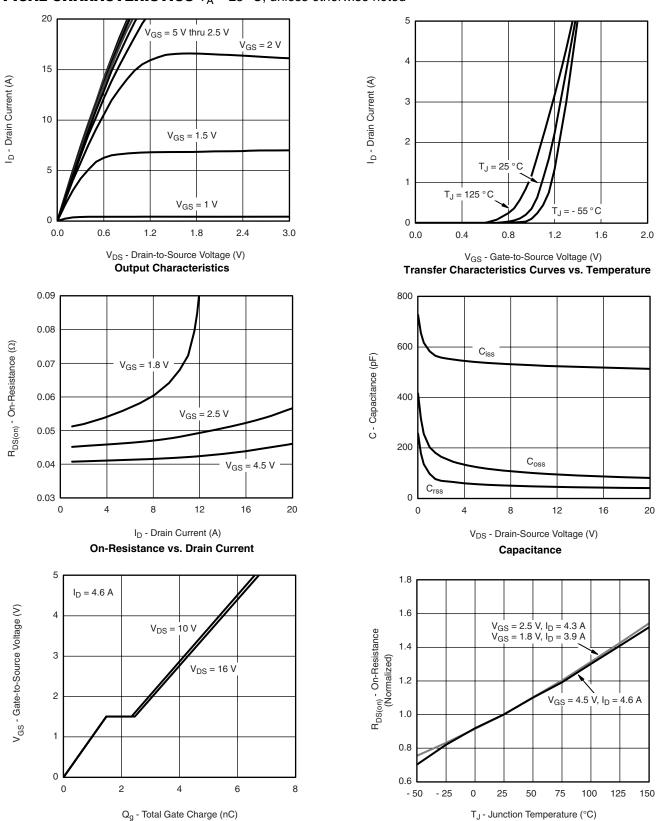
b. Guaranteed by design, not subject to production testing.







TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



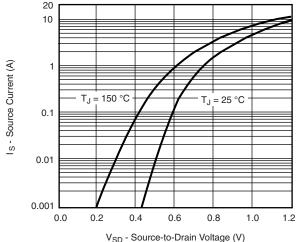
Gate Charge

On-Resistance vs. Junction Temperature

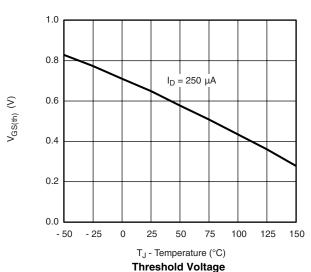
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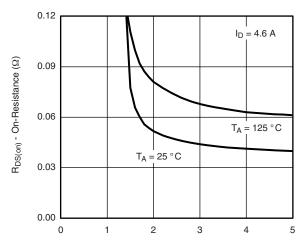
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TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted

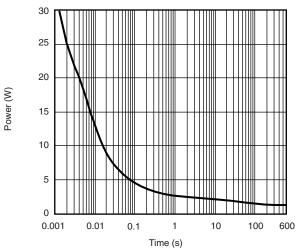


Source-Drain Diode Forward Voltage

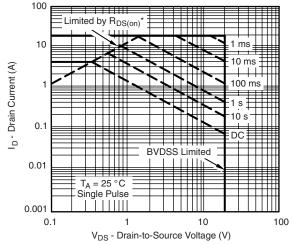




 V_{GS} - Gate-to-Source Voltage (V) $\mathbf{R}_{DS(on)}$ vs. V_{GS} vs. Temperature



Single Pulse Power



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

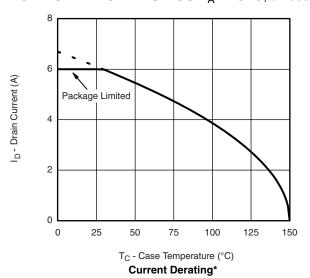
Safe Operating Area, Junction-to-Ambient

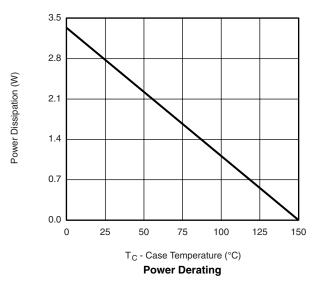






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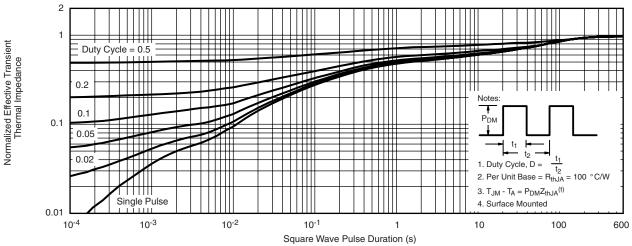


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

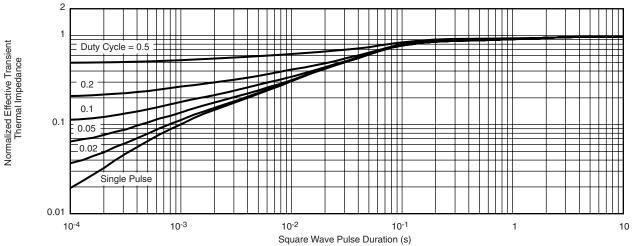
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TYPICAL CHARACTERISTICS $T_A = 25 \, ^{\circ}C$, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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